

Notice of References Cited

Application/Control No.

10/006,014

Applicant(s)/Patent Under
Reexamination
SU ET AL.

Examiner

Simon J. Oh

Art Unit

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5288491	02-1994	Moniz	424/195.1
*	B	US-6254913	07-2001	Wadsworth et al.	426/481
	C	US-			
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*	N	WO 01/15553 A1	03-2001	WIPO	Nair et al.	A23L 1/30
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	S					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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